# **MOSFET** – Power, Single, N-Channel, SO-8FL 30 V, 130 A

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb–Free Devices

#### Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Vol	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>θJA</sub>		$T_A = 25^{\circ}C$	۱ <sub>D</sub>	21	А
(Note 1)		$T_A = 85^{\circ}C$	1	15	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P <sub>D</sub>	2.31	W
Continuous Drain		$T_A = 25^{\circ}C$	ID	13	А
Current R <sub>θJA</sub> (Note 2)	Steady State	$T_A = 85^{\circ}C$		9.5	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.9	W
Continuous Drain Current $R_{\theta,JC}$		$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	130	А
(Note 1)		$T_C = 85^{\circ}C$	1	93	
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_C = 25^{\circ}C$	P <sub>D</sub>	86.2	W
Pulsed Drain Current	$T_A = 25^{\circ}C,$ $t_p = 10 \ \mu s$		I <sub>DM</sub>	260	A
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Boo	Source Current (Body Diode)			71	А
Drain to Source DV/DT			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 32 A <sub>pk</sub> , L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$ )			EAS	512	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

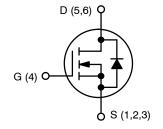
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



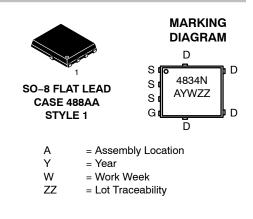
## **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	3.0 mΩ @ 10 V	
	4.0 mΩ @ 4.5 V	130 A



**N-CHANNEL MOSFET** 



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4834NT1G	SO-8FL (Pb-Free)	1500 Tape / Reel
NTMFS4834NT3G	SO-8FL (Pb-Free)	5000 Tape / Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	1.45	
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	54	°C/W
Junction-to-Ambient - Steady State (Note )	$R_{ hetaJA}$	138.7	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

## ELECTRICAL CHARACTERISTICS (T.I = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 µA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				21		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25 °C			1	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)				-	-		-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$		1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.1		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V to	I <sub>D</sub> = 30 A		2.6	3.0	
		11.5 V	I <sub>D</sub> = 15 A		2.5		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		3.5	4.0	mΩ
			I <sub>D</sub> = 15 A		3.4		
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			35.2		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>				4500		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			960		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				500		
Total Gate Charge	Q <sub>G(TOT)</sub>				32	48	
Threshold Gate Charge	Q <sub>G(TH)</sub>				5.4		1 .
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			12		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				11		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 11.5 V, V <sub>[</sub> I <sub>D</sub> = 30			74		nC
SWITCHING CHARACTERISTICS (Note 6)	•			•	•	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				20		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 1	5 V In - 15 A		34		

Turn–On Delay Time	t <sub>d(ON)</sub>		20	
Rise Time	tr	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A,	34	20
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_G = 3.0 \ \Omega$	22	ns
Fall Time	t <sub>f</sub>		23	
Turn-On Delay Time	t <sub>d(ON)</sub>	<u> </u>	11	
Rise Time	tr		23	20
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 Ω	37	ns
Fall Time	t <sub>f</sub>		15	

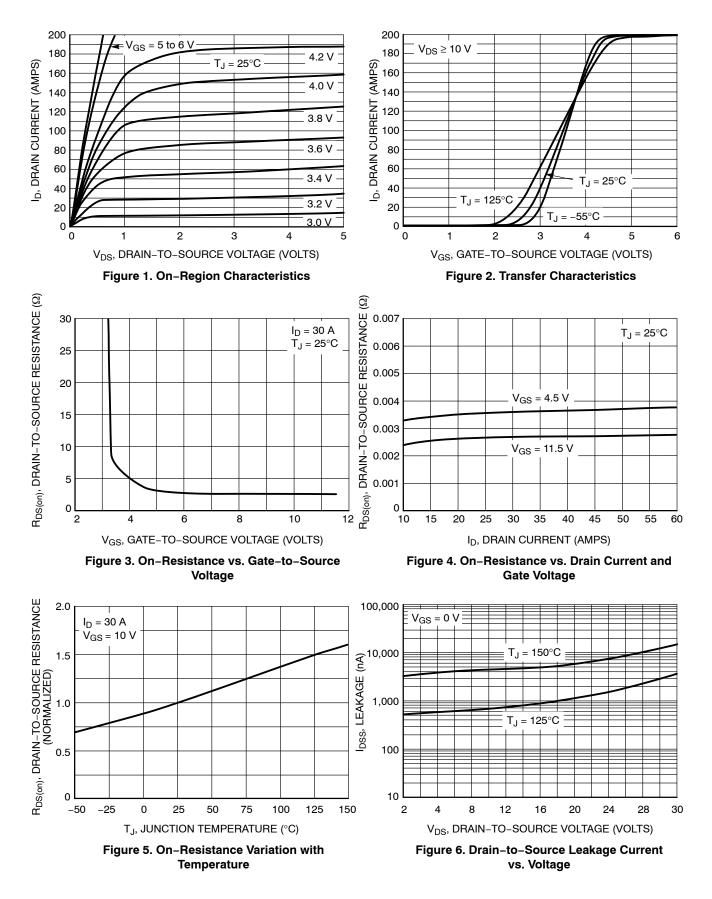
 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

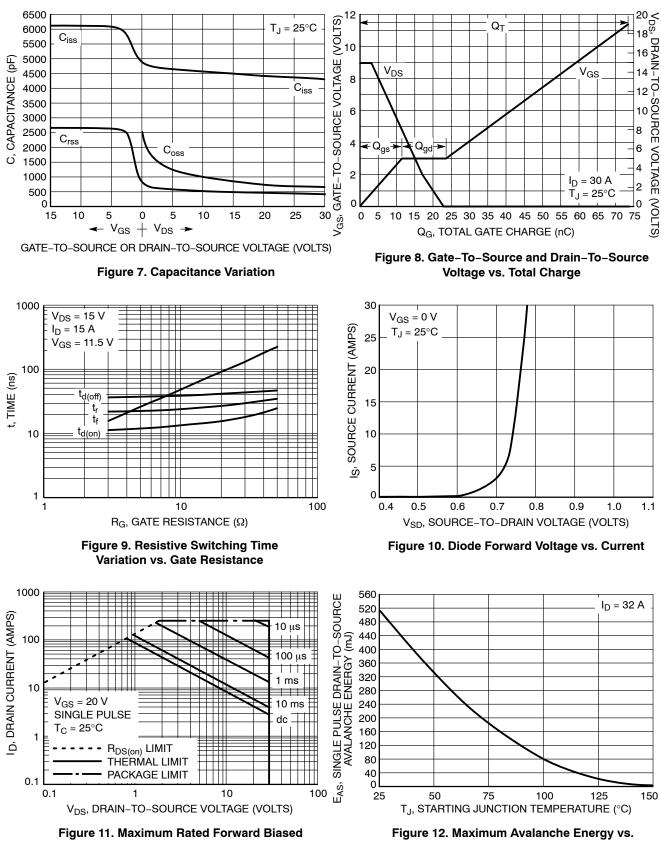
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit		
DRAIN-SOURCE DIODE CHARACTERISTICS									
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V_{1}$	$T_J = 25^{\circ}C$		0.77	1.2	Ň		
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.70		V		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 30 A			34		ns		
Charge Time	t <sub>a</sub>				18				
Discharge Time	t <sub>b</sub>				16				
Reverse Recovery Charge	Q <sub>RR</sub>				25.9		nC		
PACKAGE PARASITIC VALUES									
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.65		nH		
Drain Inductance	L <sub>D</sub>				0.005		nH		
Gate Inductance	L <sub>G</sub>				1.84		nH		
Gate Resistance	R <sub>G</sub>				1.4		Ω		

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**



## **TYPICAL PERFORMANCE CURVES**



Safe Operating Area

gure 12. Maximum Avalanche Energy v Starting Junction Temperature





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